MULTILAYER CHIP BEAD ARRAY - FBA SERIES -

FEATURES

- Monolithic inorganic material construction
- Closed magnetic circuit avoids crosstalk
- Excellent solderability and heat resistance

APPLICATIONS

- Noise elimination for four I/O lines of notebook PCs, digital TVs and VTRs, printers, hard disk drivers, personal computers and other general consumer and computer products

Casas Casas

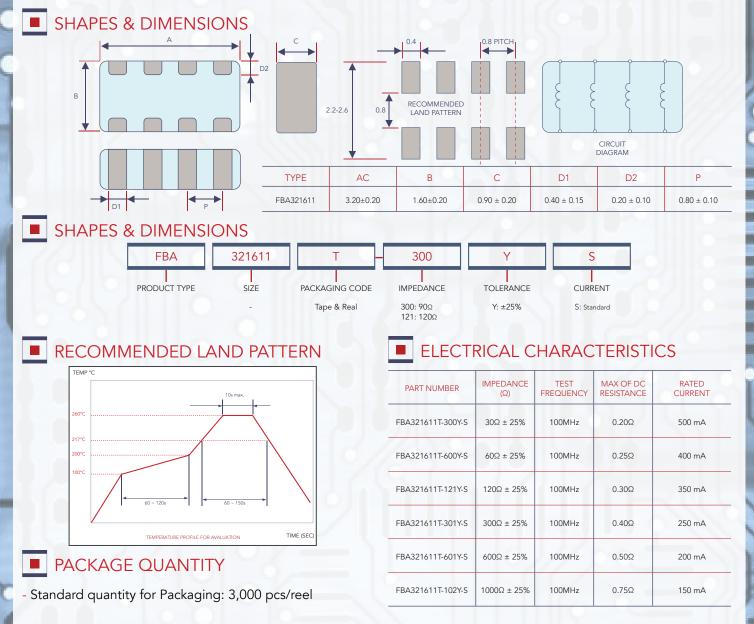


OPERATING TEMPERATURE RANGE

STORAGE TEMPERATURE

-40°C ~ + 125°C (Including self - temperature rise) 40°C MAX., 70% RHMAX.

Store this product under the condition of 5°C to 40°C, 20% to 70%RH and use within 6 months



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(Pb)(HF

RELIABILITY AND TEST CONDITION

ITEM	PERFORMANCE	TEST CONDITION
OPERATING TEMPERATURE	-55 ~ +125°C (Including self-temperature rise)	
TRANSPORTATION STORAGE TEMPERATURE	-55 ~ +125°C (on board)	For long storage conditions, please see the application notice
IMPEDANCE (Z)	Refer to standard electrical characteristics list	Agilent4291 Agilent E4991 Agilent4287 Agilent16192
DC RESISTANCE		Agilent 4338
RATED CURRENT		DC Power Supply Over Rated Current requirements, there will be some risk
TEMPERATURE RISE TEST	Rated Current < 1A Δ T 20°C Max Rated Current ≥ 1A Δ T 40°C Max	 Applied the allowed DC current Temperature measured by digital surface thermometer.
LIFE TEST	Appearance: no damage. Impedance: within ±15% of initial value DCR: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through reflow for 3 times. (IPC/JEDEC J-STD-020F Classification Reflow Profiles) Temperature: $125 \pm 2^{\circ}$ C Applied current: rated current. Duration: 1000 ± 12 hrs. Measured at room temperature after placing for 24 ± 2 hrs.
LOAD HUMIDITY		Preconditioning: Run through reflow for 3 times. (IPC/JEDEC J-STD-020-F Classification Reflow Profiles) Humidity: $85 \pm 3\%$ R.H. Temperature: $85 \pm 2^{\circ}$ C Duration: 1000hrs Min. Bead: with 100% rated current Inductance: with 10% rated current Measured at room temperature after placing for 24 ± 2 hrs.
THERMAL SHOCK	Appearance: no damage. Impedance: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through reflow for 3 times.($ PC/JEDEC J-STDSTD-020 F$ Classification Reflow Profiles) Condition for 1 cycle Step 1: -55 ± 2°C 30 ± 5 min Step 2: 125 ± 2°C 40.5 min Step 3: 125 ± 2°C 30 ± 5 min Number of cycles: 500 Measured at room temperature after placing for 24 ±2 hrs.
VIBRATION	Appearance: No damage Impedance: within ±15% in initial value DCR: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through reflow for 3 times.(IPC/JEDEC J-STDSTD-020 F Classification Reflow Profiles) Oscillation Frequency: 10Hz ~ 2KHz ~ 10Hz for 20 minutes Equipment: Vibration checker Total Amplitude: 10g Testing Time: 12 hours (20 minutes, 12 cycle each of 3 orientations)
BENDING	Appearance: No damage Impedance: within ±10% of initial value DCR: within ±15% of initial value and shall not exceed the specification value	Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch (2012mm): 40x100x1.2mm <0805 inch (2012mm): 40x100x0.8mm Bending Depth: >=0805 inch (2012mm): 1.2mm <0805 inch (2012mm): 0.8mm Duration of 10 sec for a min.
SHOCK	Appearance: No damage. Impedance: within ±10% of initial value DCR: within ±15% of initial value and shall not exceed the specification value	Test Condition VALUE NORMAL DURATION (D) (MS) WAVE FORM VELOCIT CHANGE (V) FT/SE SMD 50 11 half-sine 11.3 Lead 50 11 half-sine 11.3



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RELIABILITY AND TEST CONDITION

ITEM	PERFORMANCE	TEST CONDITION		
SOLDERABILITY	More than 95% of the terminal electrode should be covered with solder.	a. Method B, 4 hrs @155°C dry heat @ 235°C \pm 5C Test Time: 5 +0 / -0.5 seconds b. Method D category 3. (steam aging 8 hours \pm 15 min) @ 260°C \pm 5°C Test Time: 30 +0 / -0.5 seconds		
RESISTANCE TO SOLDERING HEAT	Appearance: no damage Impedance: within ± 15% of initial value DCR: within ±15% of initial value and shall not exceed the specification value	Number of heat cycles: 1 TEMPERATURE (S) TEMPERATURE RAMP/ IMMERSION AND EMERSION RATE 260 ± 5 (solder temp) 10 ± 1 25 mm /s ±6mm/s		
TERMINAL STRENGTH	Appearance: no damage Impedance: within ±15% of initial value DCR: within ±15% of initial value and shall not exceed the specification value.	Preconditioning: Run through reflow for 3 times. (IPC/JEDEC J-STD020F Classification Reflow Profiles) Component Mounted on a PCB supply a force >0805 inch (2012mm): 1kg <=0805 inch (2012mm): 0.5kg to the side of a device being tested. This force shall be applied for 60 + 1 seconds. Also the force shall be applied gradually as not to shock the component being tested.		
IMPEDANCE FREQUENCY CHARACTERISTICS FBA321611T-300Y-S FBA321611T-600Y-S				
		TROUENCY (MHz)		
- FBA321611T-121Y-S	- FBA321611T-301Y-S			
200 100 100 100 100 100 100 100 100 100		A CECUENCY (MH2)		
Cal-Chip		MS LEVEL 1		

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IMPEDANCE FREQUENCY CHARACTERISTICS

- FBA321611T-601Y-S

